AUTOMOTIVE GRADE



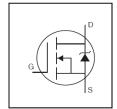
Features

- Logic Level
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *

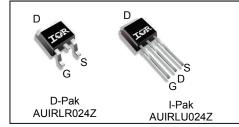
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.





V _{DSS}		55V
R _{DS(on)}	typ.	46mΩ
	max.	58mΩ
I _D		16A



G	D	S
Gate	Drain	Source

Boss nort number	Dookogo Typo	Standard Pack		Orderable Bort Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRLU024Z	I-Pak	Tube	75	AUIRLU024Z
AUIRI R0247	D. Dok	Tube	75	AUIRLR024Z
AUIKLRU24Z	D-Pak	Tape and Reel Left	3000	AUIRLR024ZTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless

	<u> </u>	. ,	
Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	16	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	11	Α
I _{DM}	Pulsed Drain Current ①	64	=
P _D @T _C = 25°C	Maximum Power Dissipation	35	W
	Linear Derating Factor	0.23	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	25	
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ®	25	- mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ®		4.28	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.053		V/°C	Reference to 25°C, I _D = 1mA
			46	58		V _{GS} = 10V, I _D = 9.6A ③
R _{DS(on)}	Static Drain-to-Source On-Resistance			80	mΩ	$V_{GS} = 5.0V, I_D = 5.0A$ 3
, ,				100		V_{GS} = 4.5V, I_D = 3.0A ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	7.4			S	V _{DS} = 25V, I _D = 9.6A ③
1	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 55V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
ı	Gate-to-Source Forward Leakage			200	A	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

•	O ,	•	,		
Q_g	Total Gate Charge	 6.6	9.9		$I_D = 5.0A$
Q_{gs}	Gate-to-Source Charge	 1.6		nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain Charge	 3.9			V _{GS} = 5.0V3
$t_{d(on)}$	Turn-On Delay Time	 8.2			$V_{DD} = 28V$
t _r	Rise Time	 43		ns	$I_{D} = 5.0A$
$t_{d(off)}$	Turn-Off Delay Time	 19		115	$R_G = 28\Omega$
t _f	Fall Time	 16			V _{GS} = 5.0V3
L_D	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5			from package and center of die contact
C_{iss}	Input Capacitance	 380			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 62			$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	 39		рF	f = 1.0MHz
C_{oss}	Output Capacitance	 180		þΓ	$V_{GS} = 0V$, $V_{DS} = 1.0V$ $f = 1.0MHz$
C_{oss}	Output Capacitance	 50			$V_{GS} = 0V$, $V_{DS} = 44V$ $f = 1.0MHz$
Coss eff.	Effective Output Capacitance	 81			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			16		MOSFET symbol
1	(Body Diode) Pulsed Source Current			64	4 A	showing the integral reverse
I _{SM}	(Body Diode) ①			04		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 9.6A, V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		16	24	ns	$T_J = 25^{\circ}C$, $I_F = 9.6A$, $V_{DD} = 28V$
Q _{rr}	Reverse Recovery Charge		11	17	nC	di/dt = 100A/μs③
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

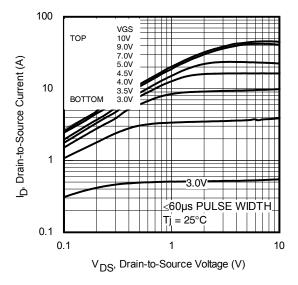
Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

- Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS
- $\$ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population, starting $T_J = 25$ °C, L = 0.54mH, $R_G = 25$ Ω, $I_{AS} = 9.6$ A, $V_{GS} = 10$ V.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

® R_θ is measured at T_J approximately 90°C.





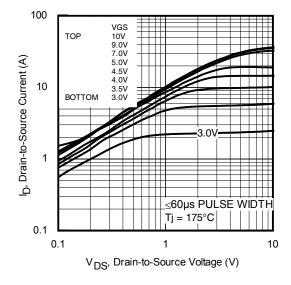
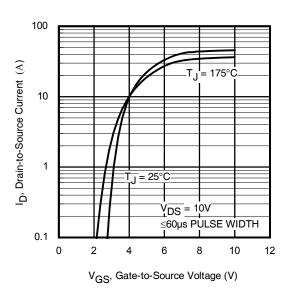


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics





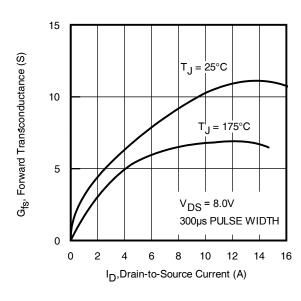


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



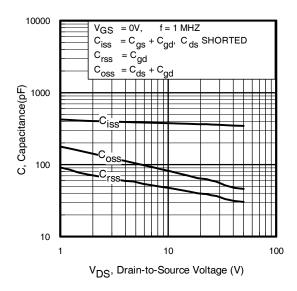


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

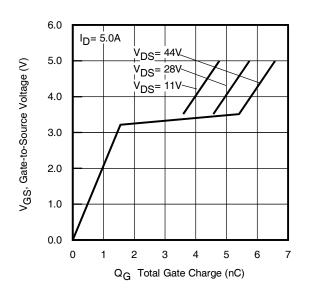


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

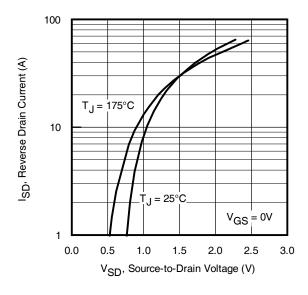


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

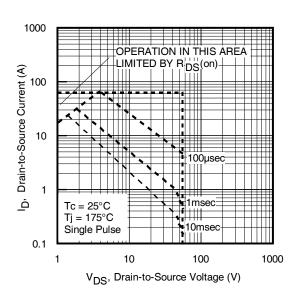
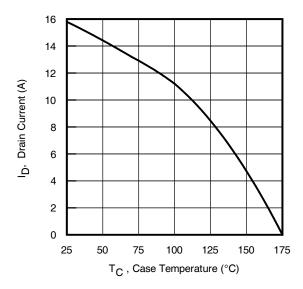


Fig 8. Maximum Safe Operating Area





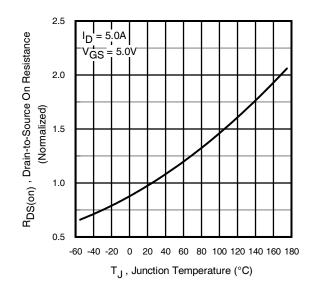


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

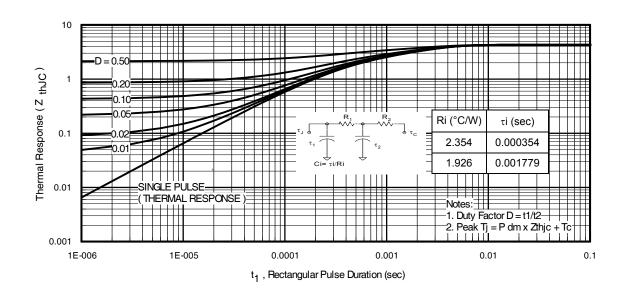


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



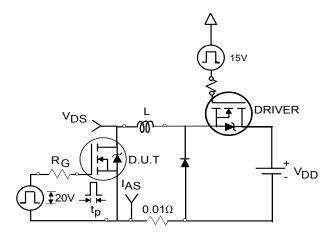


Fig 12a. Unclamped Inductive Test Circuit

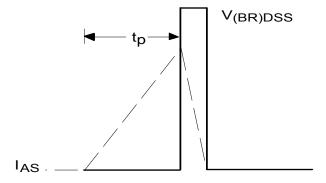


Fig 12b. Unclamped Inductive Waveforms

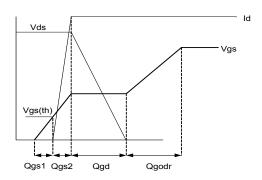


Fig 13a. Gate Charge Waveform

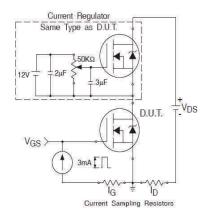


Fig 13b. Gate Charge Test Circuit

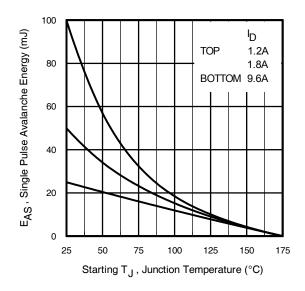


Fig 12c. Maximum Avalanche Energy vs. Drain Current

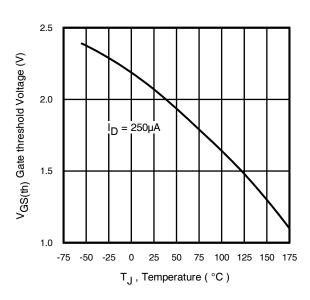


Fig 14. Threshold Voltage Vs. Temperature

2017-10-09



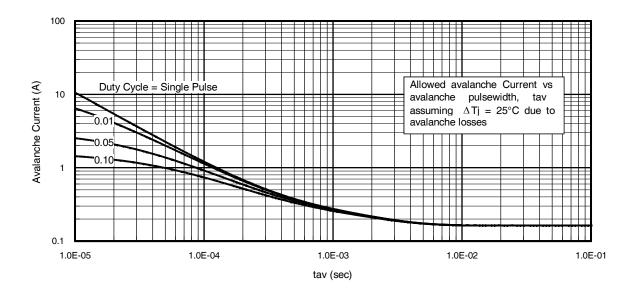


Fig 15. Typical Avalanche Current Vs. Pulse width

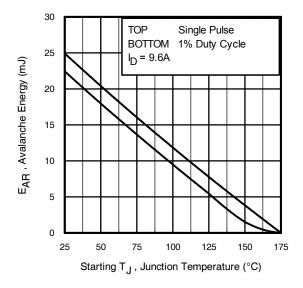


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2 \Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



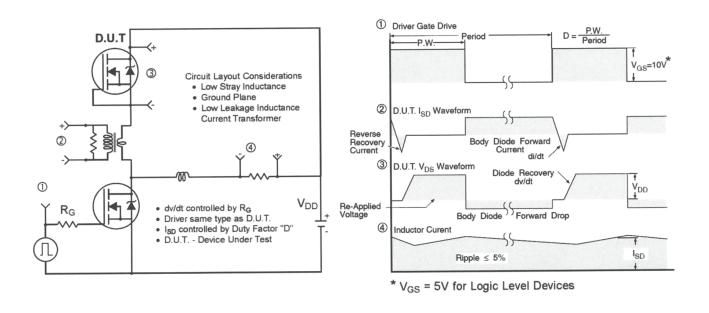
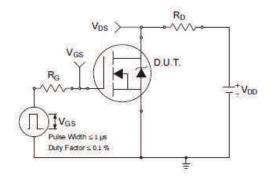
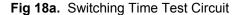


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs





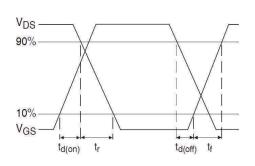
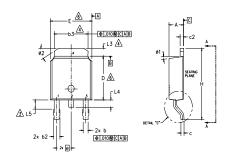


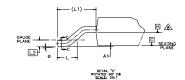
Fig 18b. Switching Time Waveforms

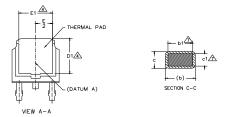


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S					
Y M		DIMEN	SIONS		N
B	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
e	2.29 BSC		.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0,	10*	0,	10°	
ø1	0,	15*	0,	15*	
ø2	25*	35°	25*	35*	

LEAD ASSIGNMENTS

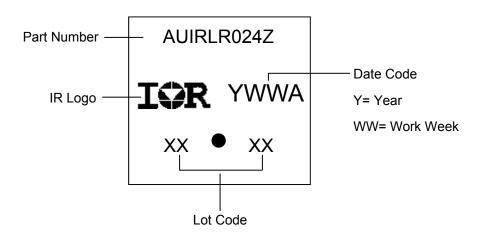
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

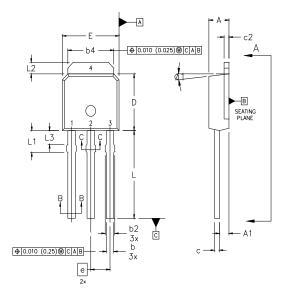
- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4. COLLECTOR

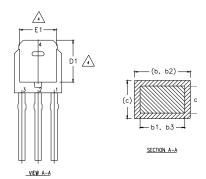
D-Pak (TO-252AA) Part Marking Information





I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 3
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
- LEAD DIMENSION UNCONTROLLED IN L3.
- DIMENSION 61, 63 APPLY TO BASE METAL ONLY. OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
 - CONTROLLING DIMENSION : INCHES.

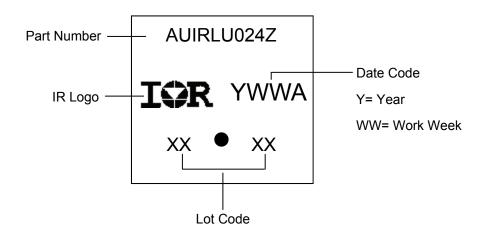
LEAD ASSIGNMENTS

ŀ	НE	X	F	Ε.	I
_					

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	2.18	2.39	0.086	.094	
A1	0.89	1.14	0.035	0.045	
b	0.64	0.89	0.025	0.035	
ь1	0.64	0.79	0.025	0.031	4
b2	0.76	1.14	0.030	0.045	
b3	0.76	1.04	0.030	0.041	
b4	5.00	5.46	0.195	0.215	4
С	0.46	0.61	0.018	0.024	
c1	0.41	0.56	0.016	0.022	
c2	.046	0.86	0.018	0.035	
D	5.97	6.22	0.235	0.245	3, 4
D1	5.21	-	0.205	-	4
E	6.35	6.73	0.250	0.265	3, 4
E1	4.32	-	0.170	-	4
e	2.	29	0.090	BSC	
L	8.89	9.60	0.350	0.380	
L1	1.91	2.29	0.075	0.090	
L2	0.89	1.27	0.035	0.050	4
L3	1,14	1.52	0.045	0.060	5
ø1	0,	15*	0*	15*	

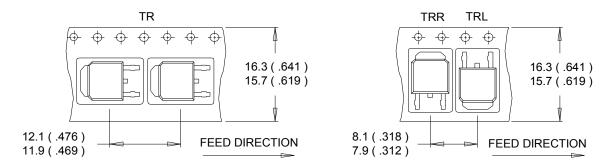
I-Pak (TO-251AA) Part Marking Information



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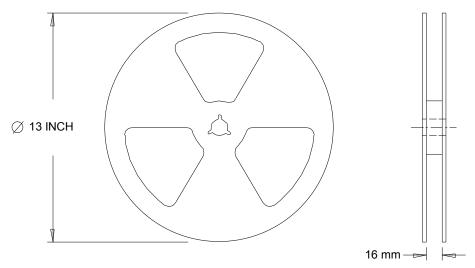


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.



Qualification Information

	don mormation					
			Automotive (per AEC-Q101)			
Qualification Level			(per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		D-Pak	MCI 1			
		I-Pak	MSL1			
	Machine Madel	Class M1B (+/-100V) [†]				
	Machine Model		AEC-Q101-002			
FOD	Homes Bade Madal	Class H0 (+/-250V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Observed Davis a Madal		Class C5 (+/-1125V) [†]			
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				
		1				

[†] Highest passing voltage.

Revision History

Date	Comments
12/11/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Corrected typo RTHJA -(PCB Mount) from "40°C/W" to "50°C/W" on page 1.
10/09/2017	Corrected typo error on part marking on page 9,10.

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Mouser Electronics

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